

Vishay Siliconix

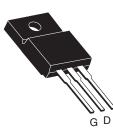
RoHS

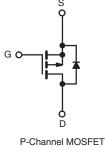
COMPLIANT

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	- 100				
R _{DS(on)} (Ω)	V _{GS} = - 10 V	0.30			
Q _g (Max.) (nC)	38				
Q _{gs} (nC)	6.8				
Q _{gd} (nC)	21				
Configuration	Single				

TO-220 FULLPAK





FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- P-Channel
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION		
Package	TO-220 FULLPAK	
Lead (Pb)-free	IRFI9530GPbF	
	SiHFI9530G-E3	
SnPb	IRFI9530G	
	SiHFI9530G	

ABSOLUTE MAXIMUM RATINGS	c = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	- 100	V	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V at 10.V	$T_C = 25 \degree C$ $T_C = 100 \degree C$	1	- 7.7		
	v_{GS} at - 10 v	T _C = 100 °C	I _D	- 5.4	А	
Pulsed Drain Current ^a			I _{DM}	- 31		
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	380	mJ	
Repetitive Avalanche Current ^a			I _{AR}	- 7.7	А	
Repetitive Avalanche Energy ^a			E _{AR}	4.2	mJ	
Maximum Power Dissipation	T _C =	25 °C	PD	42	W	
Peak Diode Recovery dV/dt ^c			dV/dt	- 5.5	V/ns	
Operating Junction and Storage Temperature Rang	erating Junction and Storage Temperature Range			- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for	10 s	-	300 ^d		
Mounting Torque	6.00 or 1	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF M3 SCIEW			1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 9.6 μ H, R_G = 25 Ω , I_{AS} = 7.7 A (see fig. 12).
- c. $I_{SD} \leq$ 7.7 A, dI/dt \leq 140 A/µs, $V_{DD} \leq V_{DS}, \, T_J \leq$ 175 °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RA	TINGS							
PARAMETER	SYMBOL	TYP. MAX.			UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65			°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.6						
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,		vise noted				1		
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static		1			0	T	0	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	250 μΑ	- 100	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I _D = 1 mA	-	- 0.10	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	V_{GS} , $I_D = 2$	250 μΑ	- 2.0	-	-4 .0	V
Gate-Source Leakage	I _{GSS}	N	$I_{\rm GS} = \pm 20$	V	-	-	± 100	nA
Zero Gate Voltage Drain Current		V _{DS} = - 100 V, V _{GS} = 0 V			-	-	- 100	μΑ
Zero Gale Voltage Drain Current	IDSS	V _{DS} = - 80 V	/ _{DS} = - 80 V, V _{GS} = 0 V, T _J = 150 °C			-	- 500	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D =	= - 4.6 A ^b	-	-	0.30	Ω
Forward Transconductance	9 _{fs}	V _{DS} = -	50 V, I _D =	- 4.6 A ^b	3.4	-	-	S
Dynamic								
Input Capacitance	C _{iss}	$V_{GS} = 0 V, V_{DS} = -25 V, f = 1.0 MHz, see fig. 5$		-	860	-	pF	
Output Capacitance	C _{oss}			-	340	-		
Reverse Transfer Capacitance	C _{rss}			-	93	-		
Drain to Sink Capacitance	С		f = 1.0 MHz	2	-	12	-	
Total Gate Charge	Qg				-	-	38	
Gate-Source Charge	Q _{gs}			A, $V_{DS} = -80$ V,	-	-	6.8	nC
Gate-Drain Charge	Q _{gd}		566 H	e fig. 6 and 13 ^b	-	-	21	
Turn-On Delay Time	t _{d(on)}				-	12	-	
Rise Time	t _r	V _{DD} =	- 50 V, I _D =	- 12 A,	-	52	-	
Turn-Off Delay Time	t _{d(off)}	$\overline{R}_{G} = 12 \Omega, R_{D} = 3.9 \Omega,$ see fig. 10^{b}		-	31	-	ns	
Fall Time	t _f	-	g		-	39	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-		
Internal Source Inductance	Ls			-	7.5	-	nH	
Drain-Source Body Diode Characteristic	cs							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	- 7.7	A	
Pulsed Diode Forward Currenta	I _{SM}	integral reverse p - n junction diode			-	-		- 31
Body Diode Voltage	V_{SD}	$T_{J} = 25 \ ^{\circ}\text{C}, \ I_{S} = -\ 7.7 \ \text{A}, \ V_{GS} = 0 \ V^{b}$		-	-	- 6.3	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = -12 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}^b$		-	120	240	ns	
Body Diode Reverse Recovery Charge							-	
Body Blode Hevelse Hebevery enlarge	Q _{rr}				-	0.46	0.92	μC

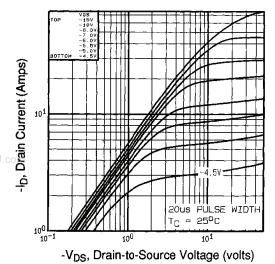
Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.

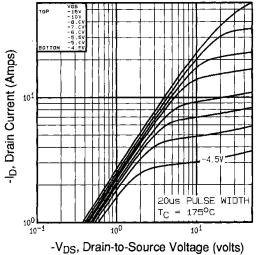


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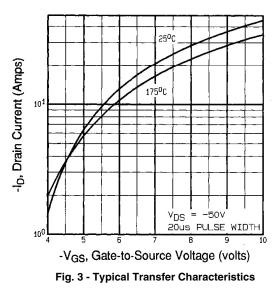


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted









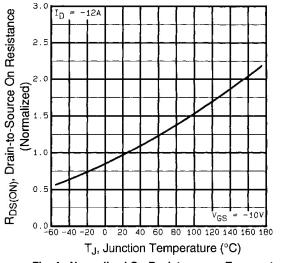
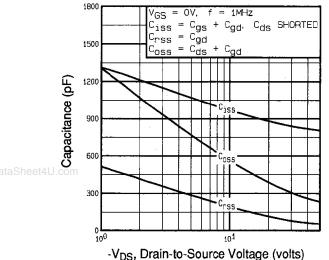
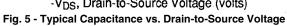


Fig. 4 - Normalized On-Resistance vs. Temperature

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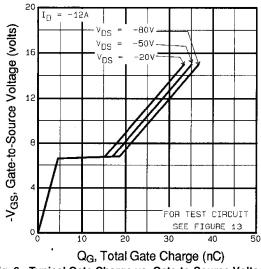
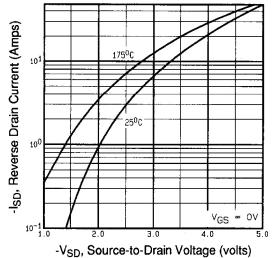
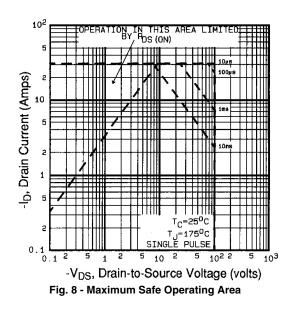


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage









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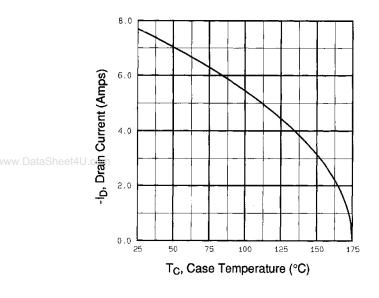


Fig. 9 - Maximum Drain Current vs. Case Temperature

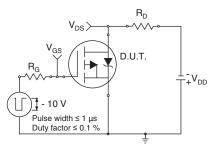


Fig. 10a - Switching Time Test Circuit

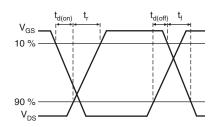
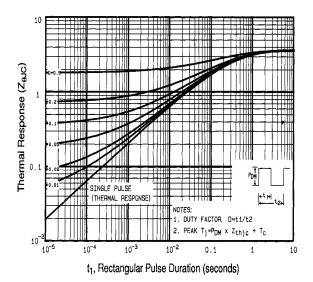


Fig. 10b - Switching Time Waveforms





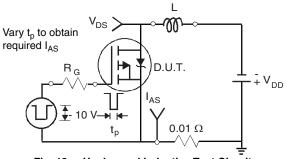


Fig. 12a - Unclamped Inductive Test Circuit

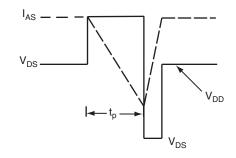
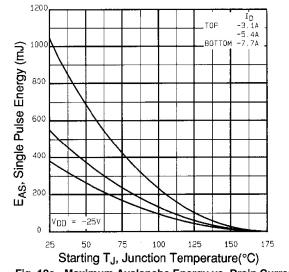
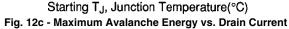


Fig. 12b - Unclamped Inductive Waveforms

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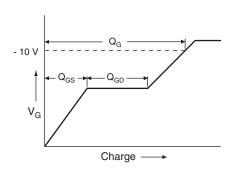
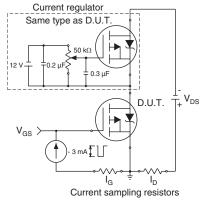
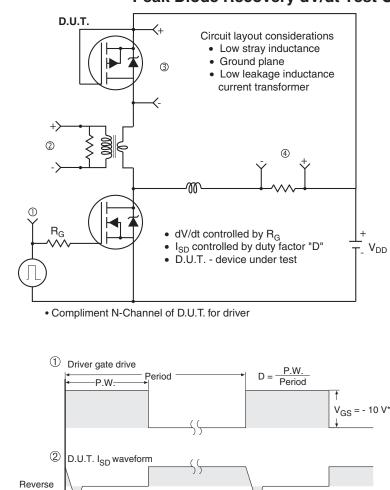


Fig. 13a - Basic Gate Charge Waveform





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Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = - 5 V for logic level and - 3 V drive devices Fig.14 - For P-Channel

Ripple ≤ 5 %

Body diode forward

Body diode forward drop

55

current

Diode recovery dV/dt

dl/dt

V_{DD}

 I_{SD}

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?91163.

recovery

3

4

D.U.T. V_{DS} waveform

Inductor current

current

Re-applied voltage



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